



N-Channel 8 V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A) ^a	Q _g (Typ.)		
8	$0.047 \text{ at V}_{GS} = 4.5 \text{ V}$	4.0 ^a			
	0.051 at V _{GS} = 2.5 V	4.0 ^a	4.24 nC		
	0.058 at V _{GS} = 1.8 V	4.0 ^a	4.24 110		
	0.069 at V _{GS} = 1.5 V	4.0 ^a			

FEATURES

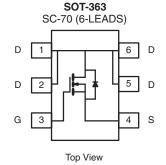
- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET[®] Power MOSFET: 1.5 V Rated
- 100 % R_g Tested
- Compliant to RoHS Directive 2002/95/EC

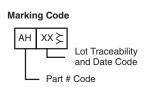


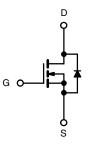


APPLICATIONS

- · Load Switch for Portable Applications
 - Guaranteed Operation at $V_{GS} = 1.5 \text{ V}$
 - Critical for Optimized Design and Space Savings







Ordering Information: Si1450DH-T1-E3 (Lead (Pb)-free)

Si1450DH-T1-GE3 (Lead (Pb)-free and Halogen-free)

N-Channel MOSFET

Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	8	V	
Gate-Source Voltage		V _{GS} ± 5		v	
	T _C = 25 °C		6.04 ^a		
Continuous Drain Current /T 150 °C)	T _C = 70 °C		4.8 ^a		
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	I _D	4.53 ^a		
	T _A = 70 °C		3.62 ^a	A	
Pulsed Drain Current		I _{DM}	15		
Continuous Source-Drain Diode Current	T _C = 25 °C	1	2.3		
	T _A = 25 °C	I _S	1.3 ^c		
Maximum Power Dissipation	T _C = 25 °C		2.78		
	T _C = 70 °C	В	1.78	W	
	T _A = 25 °C	P _D	1.56 ^{b, c}	VV	
	T _A = 70 °C		1.0 ^{b, c}		
Operating Junction and Storage Temperature Ra	T _J , T _{stg}	- 55 to 150	°C		
Soldering Recommendations (Peak Temperature) ^{d, e}			260		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, f}	t ≤ 5 s	R_{thJA}	60	80	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	R_{thJF}	34	45		

Notes:

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 5 s.
- d. Maximum under steady state conditions is 125 °C/W.

Si1450DH

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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	8			V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J 250A		8.32		m\//°C
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA		- 2.7		mV/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$	0.3		1	V
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 5 \text{ V}$			± 100	ns
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 8 V, V _{GS} = 0 V			1	
		V _{DS} = 8 V, V _{GS} = 0 V, T _J = 55 °C			10	μΑ
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le 5 \text{ V}, V_{GS} = 4.5 \text{ V}$	15			Α
	(* /	$V_{GS} = 4.5 \text{ V}, I_D = 4.0 \text{ A}$		0.039	0.047	Ω
Drain Course On State Besisters		$V_{GS} = 2.5 \text{ V}, I_D = 4.0 \text{ A}$		0.042	0.051	
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 1.8 V, I _D = 4.0 A		0.048	0.058	
		V _{GS} = 1.5 V, I _D = 1.28 A		0.053	0.069	
Forward Transconductance ^a	9 _{fs}	$V_{DS} = 4 \text{ V}, I_{D} = 4.0 \text{ A}$		15.5		S
Dynamic ^b						
Input Capacitance	C _{iss}			535		pF
Output Capacitance	C _{oss}	$V_{DS} = 4 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		120		
Reverse Transfer Capacitance	C _{rss}			61		
Total Cata Charge	0	$V_{DS} = 4 \text{ V}, V_{GS} = 5 \text{ V}, I_{D} = 4.0 \text{ A}$		4.7	7.05	
Total Gate Charge	Qg			4.24	6.4	nC
Gate-Source Charge	Q_{gs}	$V_{DS} = 4 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 4.0 \text{ A}$		1.2		
Gate-Drain Charge	Q _{gd}			0.810		
Gate Resistance	R _g	f = 1 MHz		7.3	11	Ω
Turn-On Delay Time	t _{d(on)}			8	12	
Rise Time	t _r	$V_{DD} = 4 \text{ V}, R_{L} = 1.11 \Omega$		73	110	ns
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 3.6 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		18	27	
Fall Time	t _f			5	7.5	
Drain-Source Body Diode Characteristic	s					
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			2.6	
Pulse Diode Forward Current	I _{SM}				15	А
Body Diode Voltage	V _{SD}	I _S = 2.6 A, V _{GS} = 0 V		0.8	1.2	V
Body Diode Reverse Recovery Time	t _{rr}			14.3	21.45	ns
Body Diode Reverse Recovery Charge	Q _{rr}]		3.6	5.4	nC
Reverse Recovery Fall Time	t _a	$I_F = 2.6 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		6.8		ns
Reverse Recovery Rise Time	t _b	1		7.5		

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

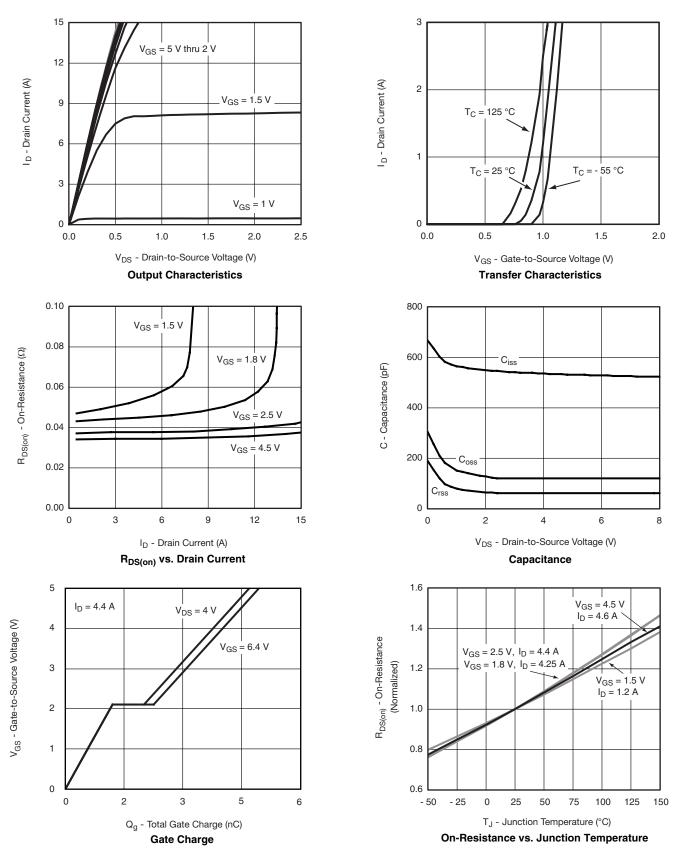
Notes: a. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %. b. Guaranteed by design, not subject to production testing.





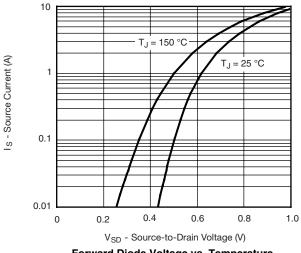


TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

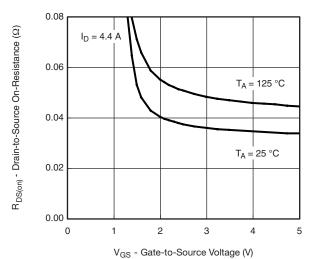


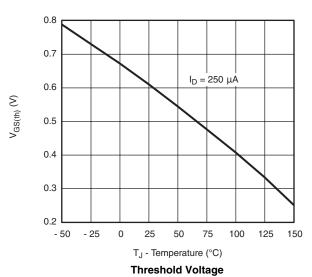
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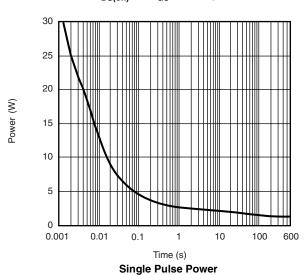


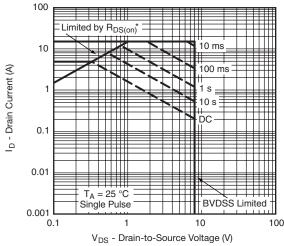
Forward Diode Voltage vs. Temperature





R_{DS(on)} vs. V_{GS} vs. Temperature





 $^{\star}\,V_{GS}>$ minimum V_{GS} at which $R_{DS(on)}$ is specified

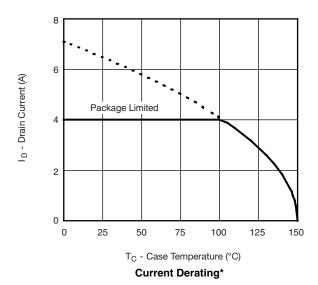
Safe Operating Area, Junction-to-Case

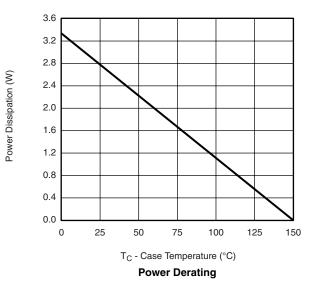






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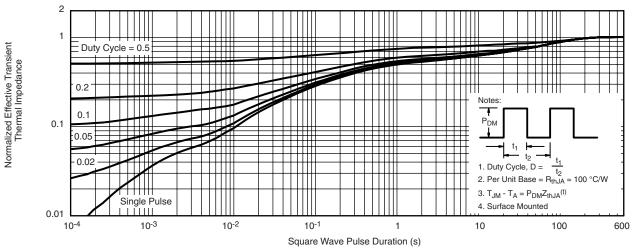


^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

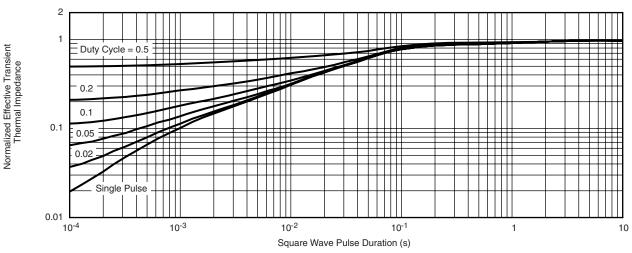
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

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Document Number: 91000 Revision: 18-Jul-08